

## **Annex P**

# **Survey Results of Low-Voltage Breakers as Found During Maintenance Testing**

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**IEEE Industrial and Commercial Power Systems  
Technical Conference  
New Orleans  
May 6–9, 1996**

Reprint from IEEE Conference Record  
96CH35920, pp. 1–4





could not be corrected by readjustment and required replacement, a trip unit failure was counted)

Trip Calibration : not able to trip within specified current and time range -required readjustment

Mechanical : springs, arms, levers, hardened lubricant, etc. - repaired or replaced

Power Contacts : alignment, incorrect pressure, pitted, etc. - repaired or replaced

Arc Chutes : chipped, cracked, burned, etc. - repaired or replaced

Auxiliary Device : auxiliary contacts, indicators, pushbuttons, etc. - repaired or replaced

OVERALL SUMMARY (TABLE 1)

Table 1 shows all circuit breakers tested and what failed during a test. The trip unit and trip calibration were the highest in failures, the percentage of failures being 2 or more times that of other failure modes.

TABLE 1

Total No. Bkrs	1174	
Total No. Tests	1989	
Total No. Failures at Test	294	
	<u>No. of</u>	<u>% of</u>
Failed Component:	<u>Fir's</u>	<u>Tests</u>
Trip Unit	109	5.5
Trip Calibration	84	4.4
Mechanical	45	2.3
Power Contacts	44	2.2
Arc Chutes	12	0.6
Auxiliary Device	10	0.5
Total No. Failed Components	*304	15.3

\* 10 circuit breakers had 2 failed components during one test

SOLID STATE TRIP UNITS VS  
ELECTROMECHANICAL TRIP UNITS - (TABLE 2)

Table 2 compares solid state (S/S) trip units to electromechanical (EM) type. Results show the EM breaker types with a higher percentage of failures (or unacceptable operation) of all components. As some would predict, the EM trip units experienced substantially more failures than the S/S type, approximately twice the percentage. Since some circuit breakers were described in the test results as in "new" condition, these have been broken out to show any influence this condition may have had on the failures.

There was no test data clearly showing EM type as "new", so it can be assumed that none of these appeared in "new" condition. The results show that the "new" S/S type, although showing some expected influence on the results, if broken out separately, would still not change this observation of EM types showing a higher percentage of failures. Another observation is that for all circuit breakers with S/S trip types, there is a more even distribution of percentage of failures over the different failure modes than for E/M types which clearly have the highest percentage of failures associated with the trip units.

TABLE 2

Trip Unit Type	All EM		All S/S		New S/S	
Total No. of Bkrs	662		512		99	
Total No. of Tests	1054		935		176	
Failed Component	# of	% of	# of	% of	# of	% of
	<u>Fir's</u>	<u>Tests</u>	<u>Fir's</u>	<u>Tests</u>	<u>Fir's</u>	<u>Tests</u>
Trip Unit	81	7.7	28	3.0	*2	1.1
Trip Calibration	60	5.7	24	2.6	*0	0.0
Mechanical	26	2.5	19	2.0	*4	2.3
Power Contacts	25	2.4	19	2.0	*5	2.8
Arc Chutes	*6	0.6	*6	0.6	*0	0.0
Auxiliary Device	*6	0.6	*4	0.4	*0	0.0
Total No. Failures	204	19.4	100	10.7	11	6.2

\* Small sample size - less than 8 failures

#### SOLID STATE vs. ELECTROMECHANICAL ACCORDING TO FRAME SIZE (TABLE 3)

Table 3 shows how circuit breakers with S/S and EM trip units compare according to frame size. The 600 amp and 800 amp frame sizes are combined since very little difference is expected in applications. Larger frame sizes include 4000 amp, but the total number breakers and tests warranted combining all sizes 1600 amp and

above. Results show a significant difference in percentage of failures between the smaller and larger frame sizes for circuit breakers with EM trip units, with the larger frame sizes higher than that of the smaller sizes. Frame size shows less effect on the difference between large and small circuit breakers with S/S trip types. EM trip units still show an obviously higher percentage of failures when compared to S/S type.

TABLE 3

Frame Size	600 A & 800 A				1600 A & Above			
	EM		S/S		EM		S/S	
Trip Unit Type	464		380		198		132	
No. of Breakers	842		778		212		157	
No. of Tests	842		778		212		157	
Failed Component	# of	% of	# of	% of	# of	% of	# of	% of
	<u>Fir's</u>	<u>Tests</u>	<u>Fir's</u>	<u>Tests</u>	<u>Fir's</u>	<u>Tests</u>	<u>Fir's</u>	<u>Tests</u>
Trip Unit	50	5.9	20	2.6	31	4.6	8	5.1
Trip Calibration	41	4.9	22	2.8	19	9.0	*2	1.3
Mechanical	17	2.0	16	2.1	*6	2.8	*3	1.9
Power Contacts	16	1.9	19	2.4	*6	2.8	*0	0.0
Arc Chutes	*6	0.7	*4	0.5	*0	0.0	*0	0.0
Auxiliary Device	*2	0.2	*3	0.4	*2	0.9	*1	0.6
Total No. Failures	132	15.7	84	10.8	64	30.2	14	8.9

\* Small sample size - less than 8 failures

**SOLID STATE vs ELECTROMECHANICAL TRIP  
CALIBRATION FAILURES (TABLE 4)**

Table 4 shows the failure relationship between the long time, short time and instantaneous settings of trip units. Some circuit breakers had more than one time setting out of calibration, evidenced by the total exceeding the

total of trip calibration failures in tables above. Some circuit breakers did not have all 3 time settings available, but practically all had instantaneous settings with the exception of a few. The results show no calibration failures for the instantaneous settings for S/S trip units.

TABLE 4

Trip Unit Type	All EM		All S/S	
	Total No. of Bkrs	Total No. of Tests	512	935
Trip Calib. Failure	# of	% of	# of	% of
	<u>Flr's</u>	<u>Tests</u>	<u>Flr's</u>	<u>Tests</u>
Long Time	45	4.3	14	1.5
Short Time	*1	0.1	11	1.2
Instantaneous	29	2.8	*0	0.0
**Total	75	7.1	25	2.7

\* Small sample size - less than 8 failures

\*\* Some circuit breakers had more than one time setting out of calibration

**OBSERVATIONS/CONCLUSIONS**

A significant observation from the results of this survey is that, for all circuit breakers, the percent of unacceptable operations of EM trip units were more than twice those with S/S trip units. This included both failure of the trip unit to operate and failure due to calibration.

EM trip units for circuit breakers rated 1600 amp and above, combined, experienced more than twice the percent of unacceptable operations as those rated 600 amp and 800 amp, combined. Again, this included both failure of the trip unit to operate and failure due to calibration.

For all circuit breakers, both percent of unacceptable operation of trip units and calibration were much higher than the other failure modes. Mechanical operation

failures and power contact failures experienced the same percentage for both EM and S/S type circuit breakers.

**ACKNOWLEDGMENT**

Appreciation is expressed to Kelly R. O'Donnell, University of Texas at San Antonio student, for contributions in data gathering and input.

**REFERENCES**

[1] "Maintaining the Integrity of a Changing Power System", by M.J. Komblit, IEEE Industry Applications Society, Oct. 7 - 12, 1990, Seattle, IEEE Catalog No. 90CH2935-9, pp 1357 - 1362